



PTO/SB/08A (08-03)

INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)			Complete If Known		
			Application Number	10/722,837	
			Filing Date	November 26, 2003	
			First Named Inventor	Hwang, Yean-Yow	
			Art Unit	3739	
			Examiner Name	Unassigned	
Sheet	1	of	9	Attorney Docket Number	022001-000902US

IDC-US Ref -41

U.S. PATENT DOCUMENTS+					
Examiner Initials*	Cite No.	Document Number Number Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
J 1	0001	US-977,825	12-06-1910	Murphy	
	0002	US-3,171,549	03-02-1965	Orloff	
	0003	US-3,280,991	10-25-1966	Melton et al.	
	0004	US-4,058,001	11-15-1977	Waxman	
	0005	US-4,128,880	12-05-1978	Cray, Jr.	
	0006	US-4,221,997	09-09-1980	Flemming	
	0007	US-4,367,998	01-11-1983	Causer	
	0008	US-4,401,852	08-30-1983	Noso et al.	
	0009	US-4,456,961	06-26-1984	Price et al.	
	0010	US-4,460,302	07-17-1984	Moreau et al.	
	0011	US-4,474,174	10-02-1984	Petruzzi	
	0011	US-4,750,136	06-07-1988	Arpin	
	0012	US-4,491,135	01-01-1985	Klein	
	0013	US-4,503,854	03-12-1985	Jako	
	0014	US-4,517,963	05-21-1985	Michel	
	0015	US-4,523,884	06-18-1985	Clement et al.	
	0016	US-4,586,398	05-06-1986	Yindra	
	0017	US-4,604,016	08-05-1986	Joyce	
	0018	US-4,616,637	10-14-1986	Caspari et al.	
	0019	US-4,624,011	11-18-1986	Watanabe et al.	
	0020	US-4,633,389	12-30-1986	Tanaka et al.	
	0021	US-4,635,292	01-06-1987	Mori et al.	
	0022	US-4,641,292	02-03-1987	Tunnell et al.	
	0023	US-4,655,257	04-07-1987	Iwashita	
	0024	US-4,672,963	06-16-1987	Batten Barken	
	0025	US-4,676,243	06-30-1987	Clayman	
	0026	US-4,728,974	03-01-1988	Nio et al.	
	0027	US-4,762,455	08-09-1988	Coughlan et al.	
	0028	US-4,791,934	12-20-1988	Brunnett	
	0029	US-4,791,940	12-20-1988	Hirschfeld et al.	
	0030	US-4,794,912	01-03-1989	Lia	
	0031	US-4,815,006	03-21-1989	Andersson et al.	
	0032	US-4,815,450	03-28-1989	Patel	
	0033	US-4,837,734	06-06-1989	Ichikawa et al.	
	0034	US-4,852,083	07-25-1989	Niehaus et al.	
	0035	US-4,853,874	08-01-1989	Iwamoto et al.	
	0036	US-4,854,301	08-08-1989	Nakajima	
	0037	US-4,860,215	08-22-1989	Serafi	
	0038	US-4,863,133	09-05-1989	Bonnell	
	0039	US-4,883,400	11-28-1989	Kuban et al.	
0040	US-4,930,494	06-05-1990	Takehana et al.		

Examiner Signature	<i>Am / hr</i>	Date Considered	5/16/05
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* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. ¹ Applicant's unique citation designation number (optional). ² Kind Codes of U.S. Patent Documents at www.uspto.gov or MPEP 901.04. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.

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Substitute Form PTO-1449

U.S. Department of Commerce
Patent and Trademark OfficeAttorney's Docket No.
11030-007004Application No.
10/722,837**Information Disclosure Statement
by Applicant**

(Use several sheets if necessary)

Applicant
Yulun Wang et al.Filing Date
November 26, 2003Group Art Unit
3739

(37 CFR 1.98(b))

IDC-US Ref -27

U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
<i>A</i>	AA	4,158,750	06/19/79	Sakoe et al.			
	AB	4,207,959	06/17/80	Youdin et al.			
	AC	4,216,462	08/05/80	McGrath et al.			
	AD	4,624,002	11/18/86	Watanabe			
	AE	4,750,136	06/07/88	Arpin et al.			
	AF	4,776,016	10/04/88	Hansen			
	AG	4,807,723	02/21/89	Haendle			
	AH	4,817,050	03/28/89	Komastu			
	AI	5,230,023	07/20/93	Nakano			
	AJ	5,274,862	01/04/94	Palmer, Jr. et al.			
	AK	5,372,147	12/13/94	Lathrop, Jr. et al.			
	AL	5,436,542	07/01/95	Petelin et al.			
	AM	5,443,384	08/22/95	Kirsch et al. Franseen, et al.			
	AN	5,482,073	01/09/96	Strum Winnie, et al.			
	AO	5,490,843	02/13/96	Hildwein et al.			
	AP	5,500,854	03/19/96	Uotila			
	AQ	5,511,256	04/30/96	Capaldi			
	AR	5,566,272	10/15/96	Brems et al.			
	AS	5,627,584	05/06/97	Nishikori et al.			
	AT	5,640,953	06/24/97	Bishop et al.			
	AU	5,713,350	02/03/98	Yokota et al.			
	AV	5,715,548	02/10/98	Weismiller et al.			
	AW	5,715,823	02/10/98	Wood			
	AX	5,729,659	03/17/98	Potter			
	AY	5,771,511	06/30/98	Kummer et al.			
	AZ	5,774,841	06/30/98	Salazar et al.			
	AAA	5,788,688	08/04/98	Bauer et al.			

Examiner Signature

Date Considered

EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Substitute Disclosure Form (PTO-1449)

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 11030-007004	Application No. 10/722,837
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Yulun Wang et al.	
		Filing Date November 26, 2003	Group Art Unit 3739

IDC-US Ref -20				U.S. Patent Documents			
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
A	ABB	5,802,467	09/01/98	Salazar et al.			
	ACC	5,809,591	09/22/98	Capaldi et al.			
	ADD	5,812,978	09/22/98	Nolan			
	AEE	5,841,950	11/24/98	Wang et al.			
	AFF	5,857,967	01/12/99	Frid et al.			
	AGG	5,877,819	03/02/99	Branson			
	AHH	5,884,350	03/23/99	Kurze			
	AII	5,895,461	04/20/99	De La Hueraga			
	AJJ	5,897,498	04/27/99	Canfield et al.			
	AKK	5,924,074	07/13/99	Evans			
	ALL	5,970,457	10/19/99	Brant et al.			
	AMM	5,976,156	11/02/99	Taylor et al.			
	ANN	6,081,181	06/27/00	Jensen et al.	6,080,181		
	AOO	6,201,984	03/13/01	Liang et al. Funda et al.			
	APP	6,224,542	05/01/01	Chang et al.			
	AQQ	6,463,361	10/08/02	Wang et al.			
	ARR	6,496,099	12/17/02	Wang et al.			
	ASS	6,642,836	11/04/03	Wang et al.			
	ATT	6,646,541	11/11/03	Wang et al.			
	AUU	6,850,817	02/01/05	Green			

IDC-For Ref -4

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
A	AVV	2642882	08/10/90	FR			Abstr.	
	AWW	95/01757	01/19/95	WO				
	AXX	96/09587	03/29/96	WO				
	AYY	98/25666	06/18/98	WO				

Examiner Signature <i>[Signature]</i>	Date Considered 02/28/06
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